

January 1999 Revised November 2000

74LVT16245 • 74LVTH16245 Low Voltage 16-Bit Transceiver with 3-STATE Outputs

General Description

The LVT16245 and LVTH16245 contain sixteen non-inverting bidirectional buffers with 3-STATE outputs and is intended for bus oriented applications. The device is byte controlled. Each byte has separate control inputs which can be shorted together for full 16-bit operation. The T/R inputs determine the direction of data flow through the device. The $\overline{\text{OE}}$ inputs disable both the A and B ports by placing them in a high impedance state.

The LVTH16245 data inputs include bushold, eliminating the need for external pull-up resistors to hold unused inputs

These non-inverting transceivers are designed for low-voltage (3.3V) V_{CC} applications, but with the capability to provide a TTL interface to a 5V environment. The LVT16245 and LVTH16245 are fabricated with an advanced BiCMOS technology to achieve high speed operation similar to 5V ABT while maintaining low power dissipation.

Features

- Input and output interface capability to systems at 5V V_{CC}
- Bushold data inputs eliminate the need for external pullup resistors to hold unused inputs (74LVTH16245), also available without bushold feature (74LVT16245).
- Live insertion/extraction permitted
- Power Up/Down high impedance provides glitch-free bus loading
- Outputs source/sink -32 mA/+64 mA
- Functionally compatible with the 74 series 16245
- Latch-up performance exceeds 500 mA
- ESD performance:

Human-body model > 2000V Machine model > 200V

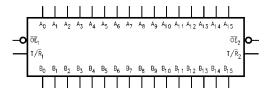
Charged-device model > 1000V

Ordering Code:

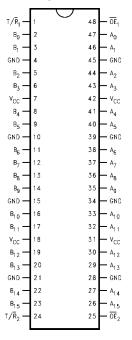
Order Number	Package Number	Package Description
74LVT16245MEA	MS48A	48-Lead Small Shrink Outline Package (SSOP), JEDEC MO-118, 0.300 Wide
74LVT16245MTD	MTD48	48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide
74LVTH16245MEA	MS48A	48-Lead Small Shrink Outline Package (SSOP), JEDEC MO-118, 0.300 Wide
74LVTH16245MTD	MTD48	48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description
OE _n	Output Enable Input (Active LOW)
T/R _n	Transmit/Receive Input
A ₀ -A ₁₅	Side A Inputs/3-STATE Outputs
B ₀ -B ₁₅	Side B Inputs/3-STATE Outputs

Truth Tables

Inputs		Outrute			
OE ₁	T/R ₁	Outputs			
L	L	Bus B ₀ –B ₇ Data to Bus A ₀ –A ₇			
L	Н	Bus A ₀ -A ₇ Data to Bus B ₀ -B ₇			
Н	Х	HIGH–Z State on A ₀ –A ₇ ,B ₀ –B ₇			

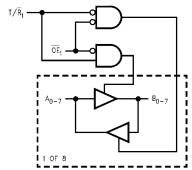
	Inp	uts	Outputs			
Γ	OE ₂	T/R ₂				
	L	L	Bus B ₈ –B ₁₅ Data to Bus A ₈ –A ₁₅			
	L	Н	Bus A ₈ –A ₁₅ Data to Bus B ₈ –B ₁₅			
Г	Н	Х	HIGH–Z State on A ₈ –A ₁₅ ,B ₈ –B ₁₅			

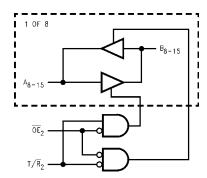
H = HIGH Voltage Level

Functional Description

The LVT16245 and LVTH16245 contain sixteen non-inverting bidirectional buffers with 3-STATE outputs. The device is byte controlled with each byte functioning identically, but independent of the other. The control pins can be shorted together to obtain full 16-bit operation.

Logic Diagrams





Note: Please note that these diagrams are provided only for the understanding of logic operations and should not be used to estimate propagation delays.

L = LOW Voltage Level

X = Immaterial

Z = High Impedance

Absolute Maximum Ratings(Note 1)

Symbol	Parameter	Value	Conditions	Units	
V _{CC}	Supply Voltage	-0.5 to +4.6		V	
VI	DC Input Voltage	-0.5 to +7.0		V	
Vo	Output Voltage	-0.5 to +7.0 Output in 3-STATE		V	
		-0.5 to +7.0	Output in HIGH or LOW State (Note 2)	·	
I _{IK}	DC Input Diode Current	-50	V _I < GND	mA	
I _{OK}	DC Output Diode Current	-50	V _O < GND	mA	
I _O	DC Output Current	64	Output at HIGH State, V _O > V _{CC}	mA	
		128	Output at LOW State, V _O > V _{CC}	IIIA	
I _{CC}	DC Supply Current per Supply Pin	±64		mA	
I _{GND}	DC Ground Current per Ground Pin	±128		mA	
T _{STG}	Storage Temperature Range	-65 to +150		°C	

Recommended Operating Conditions

Symbol	Parameter	Min	Max	Units
V _{CC}	Supply Voltage	2.7	3.6	V
VI	Input Voltage	0	5.5	V
ОН	HIGH-Level Output Current		-32	mA
OL	LOW-Level Output Current		64	mA
ΓΑ	Free-Air Operating Temperature	-40	+85	°C
Δt/ΔV	Input Edge Rate, V _{IN} = 0.8V–2.0V, V _{CC} = 3.0V	0	10	ns/V

Note 1: Absolute Maximum continuous ratings are those values beyond which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability. Functional operation under absolute maximum rated conditions is not implied.

Note 2: I_O Absolute Maximum Ratings must be observed.

DC Electrical Characteristics

Symbol	Parameter		V _{CC}	T _A = -40°C	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$		Conditions	
Syllibol	Faiaili	eter	(V)	Min	Max	Units	Conditions	
V _{IK}	Input Clamp Diode Vol	tage	2.7		-1.2	V	$I_I = -18 \text{ mA}$	
V _{IH}	Input HIGH Voltage		2.7-3.6	2.0		V	V ≤ 0.1V or	
V _{IL}	Input LOW Voltage		2.7-3.6		0.8	V	$V_O \ge V_{CC} - 0.1V$	
V _{OH}	Output HIGH Voltage		2.7-3.6	V _{CC} - 0.2			$I_{OH} = -100 \mu A$	
			2.7	2.4		V	$I_{OH} = -8 \text{ mA}$	
			3.0	2.0			$I_{OH} = -32 \text{ mA}$	
V _{OL}	Output LOW Voltage		2.7		0.2		$I_{OL} = 100 \mu\text{A}$	
			2.7		0.5		I _{OL} = 24 mA	
			3.0		0.4	V	I _{OL} = 16 mA	
			3.0		0.5		I _{OL} = 32 mA	
			3.0		0.55		I _{OL} = 64 mA	
I _{I(HOLD)}	Bushold Input Minimum Drive		3.0	75		μА	$V_{I} = 0.8V$	
(Note 3)				-75		μΛ	$V_1 = 2.0V$	
I _{I(OD)}	Bushold Input Over-Dr	ive	3.0	500		μА	(Note 4)	
(Note 3)	Current to Change Sta	te		-500			(Note 5)	
I _I	Input Current		3.6		10		$V_1 = 5.5V$	
		Control Pins	3.6		±1	μΑ	$V_I = 0V$ or V_{CC}	
		Data Pins	3.6		-5	μΑ	$V_I = 0V$	
		Data i ilis	3.0		1		$V_I = V_{CC}$	
l _{OFF}	Power Off Leakage Cu	rrent	0		±100	μΑ	$0V \le V_I \text{ or } V_O \le 5.5V$	
I _{PU/PD}	Power Up/Down 3-STA	ATE .	0–1.5		±100	μА	$V_0 = 0.5V \text{ to } 3.0V$	
	Output Current		0-1.5		±100	μΛ	$V_I = GND \text{ or } V_{CC}$	
l _{OZL}	3-STATE Output Leakage Current		3.6		-5	μΑ	$V_0 = 0.5V$	
I _{OZL} (Note 3)	3-STATE Output Leaks	age Current	3.6		-5	μΑ	$V_0 = 0.0V$	
I _{OZH}	3-STATE Output Leaka	age Current	3.6		5	μΑ	$V_0 = 3.0V$	

DC Electrical Characteristics (Continued)

Symbol	Parameter	V _{CC}	V_{CC} $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$		Units	Conditions	
Cyllidd:	T didilicter	(V)	Min	Max	0,,,,	Conditions	
I _{OZH} (Note 3)	3-STATE Output Leakage Current	3.6		5	μΑ	V _O = 3.6V	
I _{OZH} +	3-STATE Output Leakage Current	3.6		10	μΑ	$V_{CC} < V_O \le 5.5V$	
I _{CCH}	Power Supply Current	3.6		0.19	mA	Outputs HIGH	
I _{CCL}	Power Supply Current	3.6		5.0	mA	Outputs LOW	
I _{CCZ}	Power Supply Current	3.6		0.19	mA	Outputs Disabled	
I _{CCZ} +	Power Supply Current	3.6		0.19	mA	$V_{CC} \le V_O \le 5.5V$,	
						Outputs Disabled	
ΔI_{CC}	Increase in Power Supply Current	3.6		0.2	mA	One Input at V _{CC} – 0.6V	
	(Note 6)					Other Inputs at V _{CC} or GND	

Note 3: Applies to bushold versions only (74LVTH16245).

Note 4: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 5: An external driver must sink at least the specified current to switch from HIGH-to-LOW.

Note 6: This is the increase in supply current for each input that is at the specified voltage level rather than V_{CC} or GND.

Dynamic Switching Characteristics (Note 7)

Symbol	Parameter	V _{CC}	$T_A = 25^{\circ}C$		Units	Conditions	
Symbol	r al allietei	(V)	Min Typ		Max	Offics	$\textbf{C}_{\textbf{L}} = \textbf{50}~\text{pF,}~\textbf{R}_{\textbf{L}} = \textbf{500}\Omega$
V _{OLP}	Quiet Output Maximum Dynamic V _{OL}	3.3		0.8		V	(Note 8)
V _{OLV}	Quiet Output Minimum Dynamic V _{OL}	3.3		-0.8		V	(Note 8)

Note 7: Characterized in SSOP package. Guaranteed parameter, but not tested.

Note 8: Max number of outputs defined as (n). n-1 data inputs are driven 0V to 3V. Output under test held LOW.

AC Electrical Characteristics

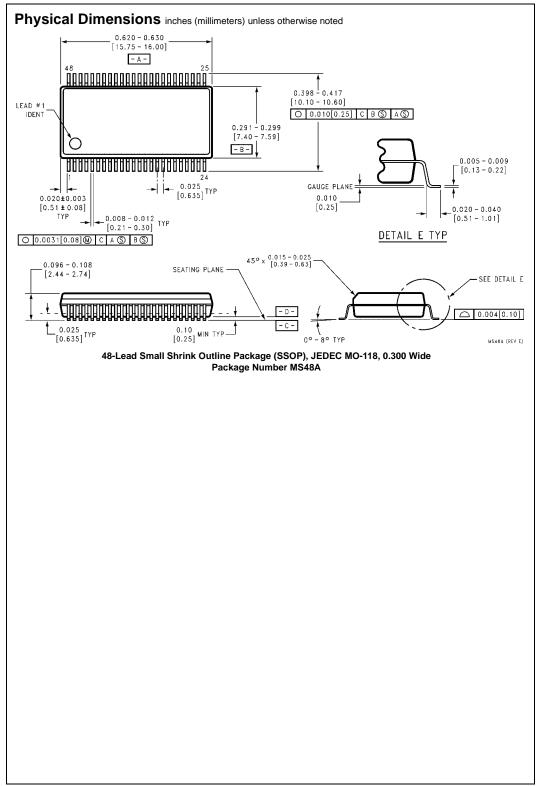
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Symbol	Parameter	V _{CC} = 3.3	3V ± 0.3V	V _{CC} =	Units	
		Min	Max	Min	Max	
t _{PLH}	Propagation Delay Data to Output	1.5	3.5	1.5	3.9	ns
t _{PHL}		1.3	3.5	1.3	3.9	115
t _{PZH}	Output Enable Time	1.5	4.5	1.5	5.3	20
t_{PZL}		1.6	5.3	1.6	6.9	ns
t _{PHZ}	Output Disable Time	2.3	5.4	2.3	6.1	ns
t_{PLZ}		2.2	5.1	2.2	5.4	115
toshl	Output to Output Skew		1.0		1.0	ns
toslh	(Note 9)		1.0			115

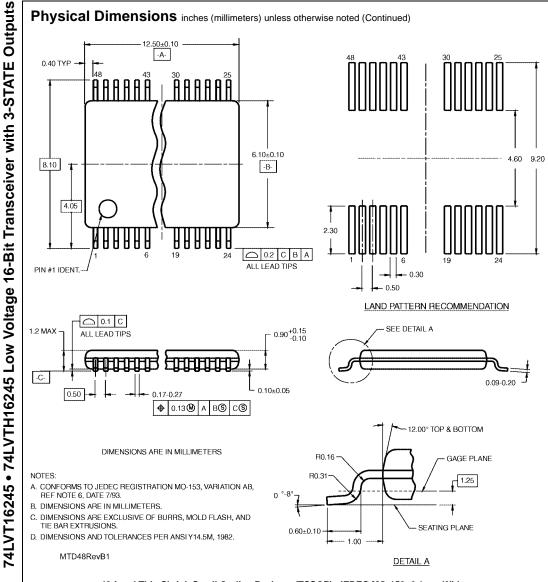
Note 9: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}). Parameter guaranteed by design.

Capacitance (Note 10)

Symbol	Parameter	Conditions	Typical	Units
C _{IN}	Input Capacitance	$V_{CC} = 0V$, $V_I = 0V$ or V_{CC}	4	pF
C _{I/O}	Input/Output Capacitance	$V_{CC} = 3.0V$, $V_{O} = 0V$ or V_{CC}	8	pF

Note 10: Capacitance is measured at frequency f = 1 MHz, per MIL-STD-883, Method 3012.





48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide Package Number MTD48

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